Application/Control No. Applicant(s)/Patent Under Reexamination 10/077,192 LAWRENCE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3629 Tan Dean D. Nguyen U.S. PATENT DOCUMENTS **Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2001/0026609 10-2001 Α Weinstein et al. 379/93.01 US-В US-С US-D US-Ε F US-G US-Н US-US-1 US-J US-K US-L М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY 2254378 10-1999 Ν Canada Woodrow 0 025401 -200 (Kovea Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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